

Search Notes

Application/Control No.

10/010,807

Examiner

Christopher L. Chin

Applicant(s)/Patent under
Reexamination

TAN ET AL.

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
428	402	2/25/2005	CC
428	402.2		
428	402.24		
428	403		
428	404		
428	405		
436	524		
436	525		
436	526		
436	527		
435	6		
435	7.21		
435	7.5	2/25/2005	CC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Checked parent patent 6,548,264	2/25/2005	CC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as	above	2/25/2005	CC